

Design of Fully Differential OpAmps for GHz Range Applications

A. Budyakov^{1,2}, K. Schmalz², N.N. Prokopenko¹, C. Scheytt², P. Ostrovskyy²

¹ South Russia State University of Economics and Service, Radiotechnic Departament,
Str. Shevchenko 147, 346500 Shakhty, Rostov region, Russia

alexbbster@gmail.com, budyakov@ihp-microelectronics.com, prokopenko@sssu.ru

² IHP, Im Technologiepark 25, 15236 Frankfurt/Oder, Germany
schmalz@ihp-microelectronics.com

Abstract— We compare the RF performance of fully differential opamps developed in 0.25 μm SiGe complementary (pnp/npn) technology and 0.13 μm SiGe BiCMOS (with npn only). Using the same compensation technique, the frequency response of these opamps is analyzed with emphasis on the phase margin (PM) and gain margin (GM). The pnp/npn opamp has advantage in unity gain bandwidth (UGB) and current consumption in comparison to the 0.13 μm BiCMOS design (supply voltage of 4V). For the pnp/npn opamp a 23 GHz UGB can be achieved with PM of 57 degrees. In case of the pnp/npn opamp the supply voltage can be reduced to 3V using a new topology with resistor for tail current. The optimized RF pnp/npn opamp allows the design of a second order 2GHz biquad bandpass filter and a differential line driver (50 Ohm) with 24 GHz bandwidth.

I. INTRODUCTION

Operational amplifiers (opamp) have moved to RF circuit design recently [1,2,3]. They can be used to design amplifiers, filters, signal conditioning circuits and line drivers. Fully differential opamps are especially attractive, because of their immunity to in-phase interference, increased dynamic range and reduced even-order harmonics. The design of an opamp for GHz range applications (RF opamp) requires very high transit frequency of the transistors because of stability problems, especially in applications with maximum negative feedback factor. To get the highest unity gain bandwidth (UGB) for a given technology, it is needed to minimize the number of transistors that process the signal from the input to the output of the opamp, that means to use a minimal “electrical length” (EL) circuits.

The influence of a transistor phase excess on phase margin of RF opamp is discussed in Section II. A comparison of RF opamps with supply voltage of 4V based on a BJT input stage (pnp/npn RF opamp) and a MOS-BJT cascode input stage (BiCMOS RF opamp) is presented in Section III. A new pnp/npn RF opamp topology for a 3V supply voltage is described in Section IV. Applications of an optimized pnp/npn RF opamp for a 2GHz biquad bandpass filter and for a differential line driver are given in Section V.

II. INFLUENCE OF DELAY ON PHASE MARGIN

Accuracy of signal conditioning in an opamp depends on the open loop gain. The open loop gain of an opamp with one pole

frequency response can be approximated at high frequency (from first pole frequency to UGB frequency) as follows:

$$A(f_s) = \frac{\text{UGB}}{f_s}, \quad (1)$$

where f_s is the signal frequency.

Further, accuracy of signal conditioning in RF applications depends mainly on UGB, because most of the spectra of the signal are usually located at RF frequency range. Thus, one can sacrifice DC open loop gain for UGB using minimal “electrical length” circuit of the RF opamp. Let’s consider an opamp with two pole transfer function, where EL is the number of transistors taking part in signal processing, from the input to the output, and $\omega_T = 2\pi f_T$ is the transit frequency:

$$A(s) = \frac{A_{dc}}{(1+s/\omega_{p1})(1+s/\omega_{p2})} \cdot e^{-s \cdot \text{EL} / \omega_T}. \quad (2)$$

Here A_{dc} is the DC open loop gain; ω_{p1} , ω_{p2} are the first and second pole frequencies.

The phase margin (PM) of an RF opamp with this transfer function was simulated (see fig.1) in SPICE with typical parameters; $A_{dc} = 200$ V/V, $\omega_{p1} = 2\pi \cdot 100 \cdot 10^6$ rad/s, $\omega_{p2} = 2\pi \cdot 30 \cdot 10^9$ rad/s, $\omega_T = 2\pi \cdot 150 \cdot 10^9$ rad/s.

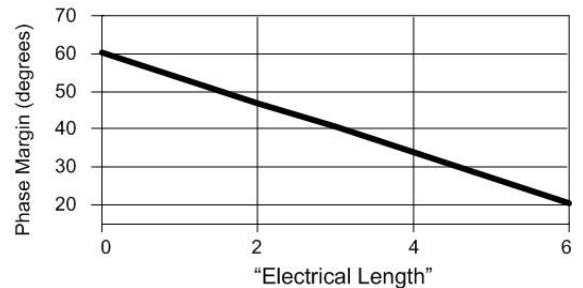


Figure 1. Phase margin of an opamp versus “electrical length” (EL) of the opamp

As fig.1 shows, the PM of the opamp degrades with increasing of EL. Therefore, it is important to design opamp topologies with minimal “electrical length” circuits, and compare use the topologies.

III. COMPARISON PNP/NPN WITH BiCMOS RF OPAMP

Optimal topologies for RF opamp with maximum negative feedback factor are circuits having a minimal number of transistors in the signal processing path, such as the circuits shown in figs.2a,b.

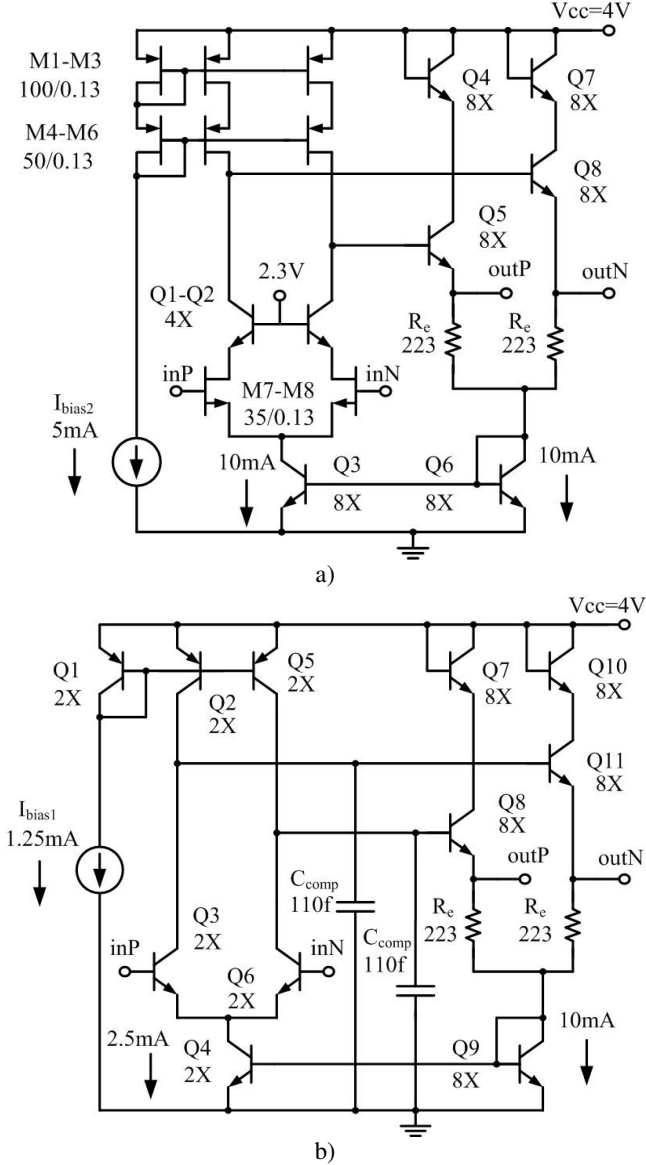


Figure 2. BiCMOS opamp (a) and pnp/npn opamp (b) circuits

The 0.13 μ m BiCMOS opamp shown in fig.2a was reported in [4,5]. We compare this RF opamp with the pnp/npn RF opamp in fig.2b. The RF opamp of fig.2b consists of a differential npn transistors (Q3 and Q6) input stage with pnp transistor load (Q2, Q5). The common mode feedback circuit (Q9, Q4) is the same

as in fig.2a. The output voltage followers Q8 and Q11 provide a low output impedance and appropriate DC voltage level (2V) to drive an identical opamp input stage. This opamp has the minimal possible “electrical length”, but still enough DC open loop gain due to the high output impedance of the pnp active loads Q2, Q5. The opamp in fig.2b is based on a 0.25 μ m SiGe complementary technology [6] (pnp transistors with $f_T=85$ GHz, $f_{max}=120$ GHz and $BV_{CEO}=2.5$ V, npn transistors with $f_T=170$ GHz, $f_{max}=170$ GHz and $BV_{CEO}=1.9$ V). The simulation of the opamp in fig.2a is based on a 0.13 μ m SiGe BiCMOS (with npn only) technology, npn transistors have $f_T=170$ GHz, $f_{max}=170$ GHz and $BV_{CEO}=1.9$ V (preliminary data for SG13B [7]).

For stable operation of an opamp with feedback, the second pole frequency of the opamp should be larger than the unity gain bandwidth frequency [8]. The second pole frequency of the opamps in figs.2a,b is defined by a time constant which is the product of the output resistance of signal source and the input capacitance of opamp.

The input capacitance of the pnp/npn opamp is dominated by the emitter-base diffusion capacitance of transistors Q3 and Q6 at frequencies close to UGB. A rough approximation of this capacitance is given by [9]:

$$C_{inp,bip} \approx \tau_b \frac{I_e}{V_T}, \quad (3)$$

where τ_b is the base transit time of Q3, Q6; I_e is the emitter DC current of Q3, Q6, $V_T \approx 26$ mV is the thermal voltage.

The input capacitance of the BiCMOS opamp, see fig.2a, is defined by the gate-source capacitance of M7, M8 and is proportional to the area ($A = W \times L$) of these transistors.

Thus, optimization of the second pole location can be performed by means of the DC collector bias current of the input stage in case of BJT input stage or the width of the input transistors in case of MOSFET input stage.

To compare the parameters for these two opamps, we have designed them with an equal single ended UGB (SE UGB). The simulation results are depicted in fig.3.

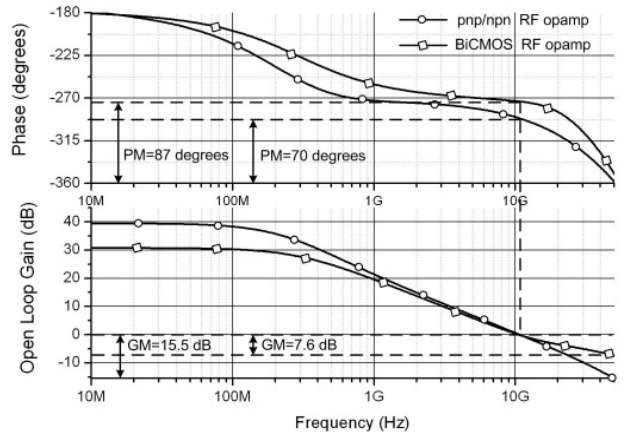


Figure 3. Simulated frequency responses of the opamps in fig.2a,b

The BiCMOS RF opamp is better phase margin, but the gain margin (GM) is worse compared to the pnp/npn RF opamp. The main parameters of these opamps are given in table 1.

TABLE I. RF OPAMP PARAMETERS

RF opamp	Parameters and Units				
	SE UGB, GHz	PM, degrees	GM, dB	DC Gain, dB	I _q , mA
pnp/npn	10.7	70	-15.5	39.4	12.5
BiCMOS	10.7	87	-7.6	30.8	20

The PM of the pnp/npn RF opamp is smaller due to the effect of loading with the capacitance C_{comp} decreases the second pole frequency for higher C_{comp} and lower input stage transconductance [9]. At frequency higher than UGB, the roll-off of the phase characteristic for the BiCMOS RF opamp is higher, because of more transistors in the signal path (EL) compared to the pnp/npn RF opamp.

IV. LOW VOLTAGE TOPOLOGY OF PNP/NPN RF OPAMP

The supply voltage of the RF opamps in figs.2a,b is restricted to 4V due to the voltage headroom of the tail current sources, Q3 (fig.2a) and Q4 (fig.2b). If the emitter-collector voltage on these transistors is less than 0.7V, the output resistance is decreased, and saturation becomes possible.

The supply voltage of an opamp can be reduced using a resistor tail current, but then the common-mode rejection ratio drops drastically. Therefore, a new topology of a fully differential pnp/npn RF opamp (fig.4) was developed, which is based on circuit design ideas in [10].

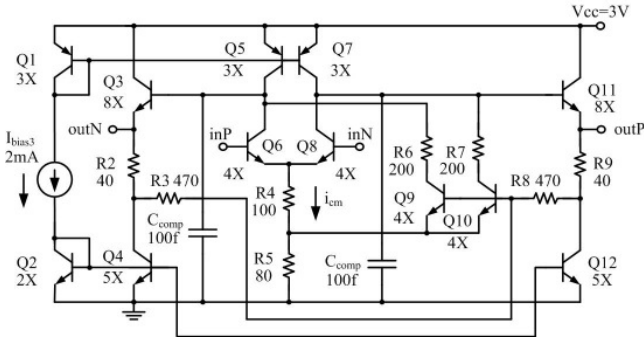


Figure 4. Low voltage fully differential pnp/npn RF opamp with resistor as the tail current

Let's consider the bias conditions of this opamp. For the given analysis a unity feedback factor for DC voltage is assumed, so that outP is connected to inN, and outN is connected to inP. The DC common-mode voltage on the inputs and outputs of the opamp is:

$$V_{CM} = V_{be6} + 2 \cdot I_{C6} R_4 + 2 \cdot I_{C5} R_5 \quad (4)$$

$$V_{CM} = 2 \cdot I_{C5} R_5 + V_{be9} + I_{C4} R_2. \quad (5)$$

From (4)-(5) we can find (assuming $V_{be6} \approx V_{be9}$):

$$I_{C6} \approx 0.5 \cdot I_{C4} \frac{R_2}{R_4}. \quad (6)$$

Further, the collector DC current of Q9 is:

$$I_{C9} = I_{C5} - I_{C6}. \quad (7)$$

The rest of the circuit is symmetrical and the DC currents are:

$$I_{C8} = I_{C6}, \quad I_{C10} = I_{C9}. \quad (8)$$

To analyze the common mode operation, we consider a simplified equivalent circuit for the common mode input signal, see fig.5.

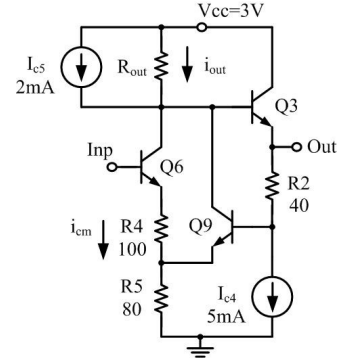


Figure 5. Equivalent half circuit of the low voltage pnp/npn RF opamp for common-mode signal

The Q6 collector current (i_{cm}) caused by the input common-mode voltage (Inp) is:

$$i_{cm} = V_{inp} / (R_4 + R_5 \parallel r_e). \quad (9)$$

The output current of the input stage is:

$$i_{out} = i_{cm} \left(1 - \alpha \frac{R_5}{r_e + R_5} \right), \quad (10)$$

where α is the emitter current gain of Q9, and r_e is the differential emitter-base junction resistance of Q9. Hence, the output voltage (Out) in fig.5 is:

$$V_{out} = V_{inp} \frac{R_{out} \left(1 - \alpha \frac{R_5}{r_e + R_5} \right)}{R_4 + R_5 \parallel r_e} \quad (11)$$

If the opamp is designed such that $\alpha \frac{R_5}{r_e + R_5} \approx 1$, the output voltage in fig.5 as well as the common-mode output voltage in fig.4 is close to zero. The results have been proved by

simulation for input and output common-mode voltages, see fig.6 (the opamp was configured with DC feedback factor of unity and AC feedback factor of zero). The simulated frequency response is depicted in fig.7 (including extracted parasitics of the opamp layout). The single-ended UGB is 8.7 GHz, while the differential one is 17.4 GHz (obtained by adding 6 dB to the simulated gain) with PM of 67 degrees. The differential output voltage swing is 890 mVp-p. The area of the opamp layout is 110 μ m \times 120 μ m without pads.

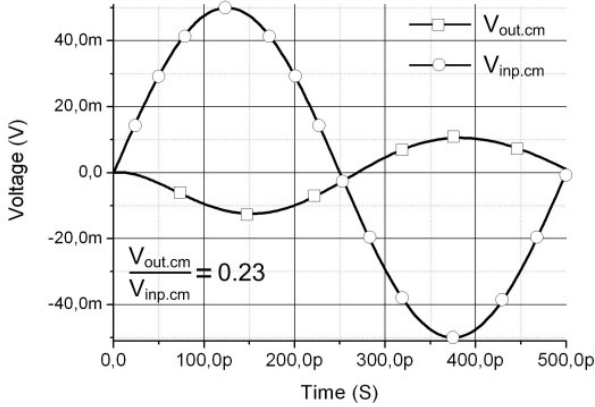


Figure 6. Input $V_{inp,cm}$ and output $V_{out,cm}$ common-mode voltages in the low voltage pnp/npn RF opamp with the input common-mode signal of 2GHz

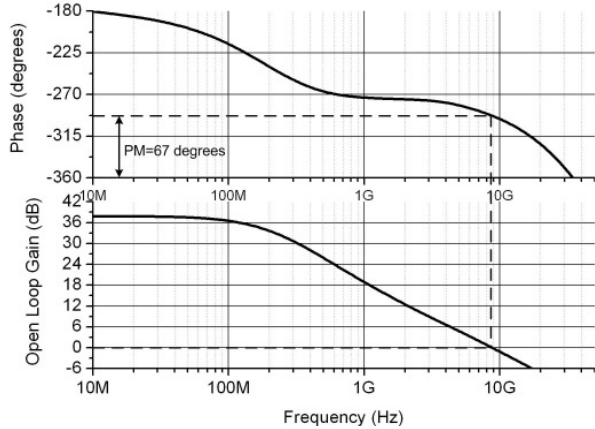


Figure 7. Simulated frequency response of the low voltage pnp/npn RF opamp

V. APPLICATIONS OF THE PNP/NPN RF OPAMP

Using the opamp topology given in fig.2b the pnp/npn opamp has been designed for maximum UGB with PM of 57 degrees. The parameters of the components are given in fig.8. The simulated frequency response of the opamp is shown in fig.9. The single-ended UGB is 12.3 GHz, while the differential one is 23 GHz. The area of the opamp layout is 110 μ m \times 130 μ m without pads. A second order 2 GHz bandpass biquad filter (fig.10) and a 50 Ohm line driver (fig.13) were designed using this RF opamp.

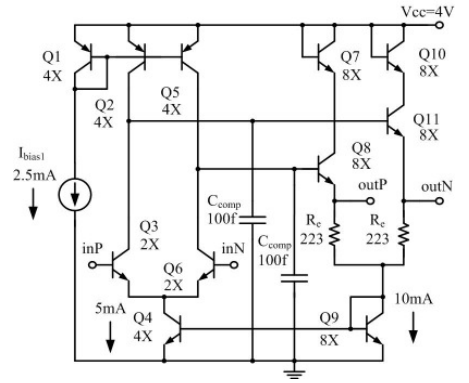


Figure 8. Pnp/npn RF opamp optimized for maximum UGB

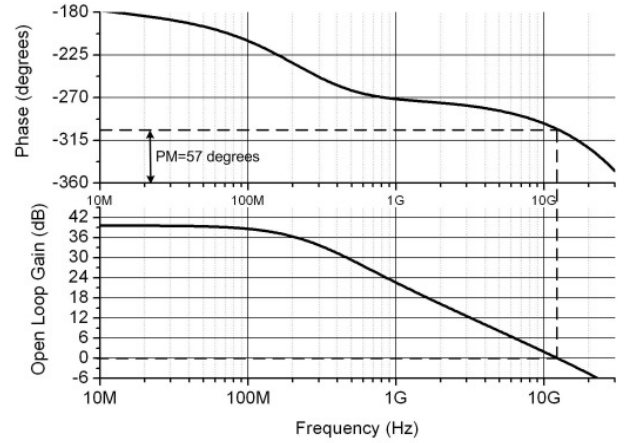


Figure 9. Simulated frequency response of the optimized pnp/npn RF opamp

The bandpass filter, see fig.10, consists of an input buffer for matching to a 50 Ohm signal source, and 1st and 2nd integrator of the biquad filter [11]. The output matching is performed by resistors R_o . The feedback passive component values have been trimmed to take into account non-idealities of the opamp. The frequency response of the filter is depicted in fig.11. The simulated input/output return losses of the filter are less -17 dB in the range 1GHz-3GHz, and IP_{1dB} and OP_{1dB} are -7dBm and -4.3dBm respectively. The differential noise figure of the filter is 21.6 dB at 2 GHz. The area of the filter layout is 0.6mm \times 0.6mm including pads (fig.12).

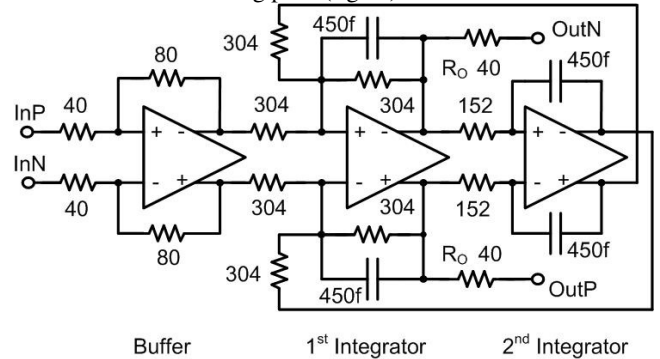


Figure 10. 2GHz bandpass biquad filter

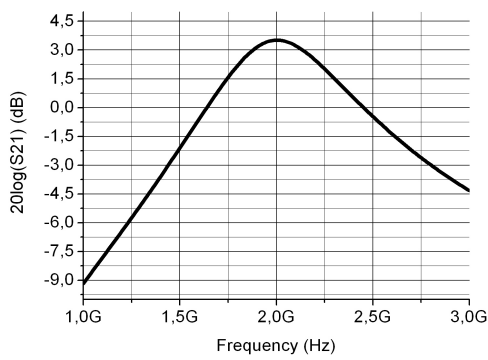


Figure 11. Simulated frequency response of the biquad filter

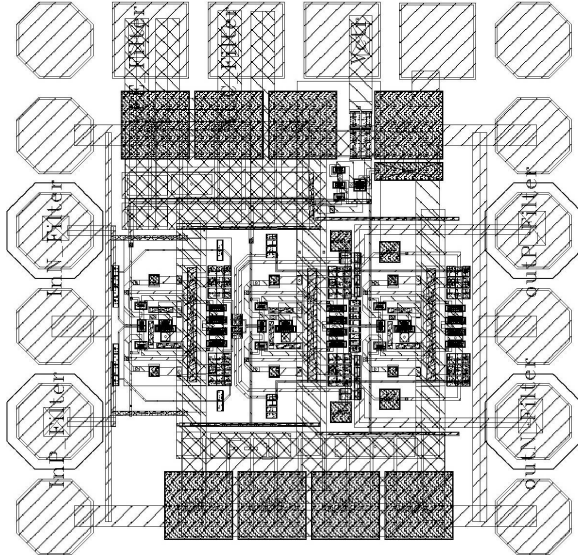


Figure 12. Layout of the RF bandpass filter (the pads are $80\ \mu\text{m} \times 80\ \mu\text{m}$)

The driver in fig.13 is an inverting opamp configuration with output resistors R_O for matching to a 50 Ohm load. The feedback resistors R_F and R_G are minimized to avoid degradation of the bandwidth, but input return loss starts to degrade at lower frequency in this case, compared to the classical line driver circuit [11]. The frequency response of the driver is presented in fig.14. The bandwidth of the driver is 24 GHz while input/output return losses are less -20 dB up to frequency of 2GHz. The OP_{1dB} is -3.2 dBm at 100 MHz for power gain of 0.6 dB. The differential noise figure of the driver is 12.5 dB up to 12 GHz.

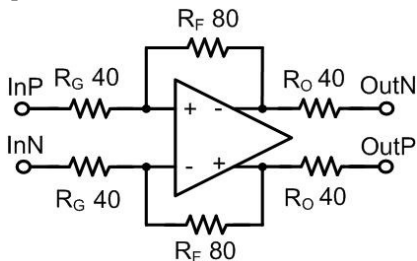


Figure 13. Line driver circuit

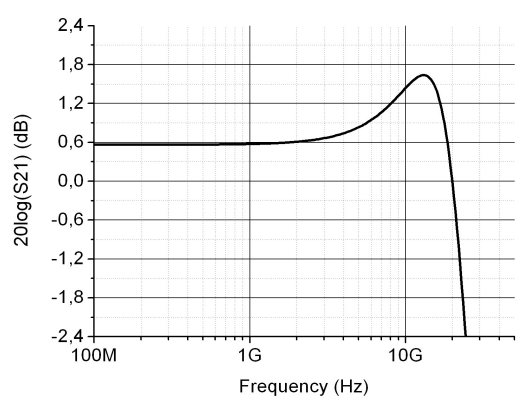


Figure 14. Simulated frequency response of the line driver

VI. CONCLUSIONS

A design methodology for RF opamps has been presented. It was shown, that an RF opamp with unity gain bandwidth of 23 GHz can be realized in a SiGe complementary technology at 4 V supply voltage with PM of 57 degrees. Applications of this RF opamp were demonstrated for a 2 GHz bandpass biquad filter and a line driver with bandwidth of 24 GHz. A circuit design approach for RF opamp with 3 V supply voltage has been developed and implemented in a $0.25\ \mu\text{m}$ SiGe complementary technology.

ACKNOWLEDGMENT

We would like to thank Samiran Halder for discussion of the paper. This work was funded by Russian Federal Agency on Education within Russian President Grant for study abroad and IHP GmbH.

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